



Transient Tests
 Trise, Tfall vs Vdd at varying CL
 CL sweep from 100p to 3.5n or as per datasheet.
 Risettime_NoOvershoot(v(g))
 Falltime_NoOvershoot(v(g))

Title		
13_Tr_vs_Cload		
Size	Document Number	Rev
A	Driver Test Circuit	0
Date:	Sunday, October 25, 2009	Sheet 1 of 1